



Features

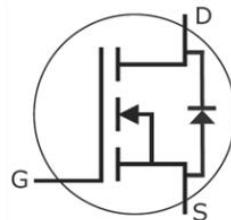
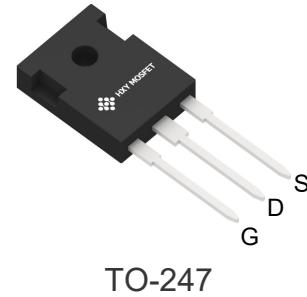
- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies



Ordering Part Number	Package	Brand
HXYS68N120MP	TO-247	HXY MOSFET

Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	1200	V
Continuous drain current $T_c = 25^\circ\text{C}$, $V_{GS} = 15\text{V}$ $T_c = 100^\circ\text{C}$, $V_{GS} = 15\text{V}$	I_D	68 48	A
Pulsed drain current ($T_c = 25^\circ\text{C}$, t_p limited by $T_{j\max}$)	$I_{D\text{ pulse}}$	120	A
Gate-Source voltage	V_{GS}	-4/+18	V
Gate-Source voltage (Absolute maximum values)	$V_{GS\max}$	-8/+22	V
Power dissipation ($T_c = 25^\circ\text{C}$)	P_{tot}	357	W
Operating junction and storage temperature	T_j , T_{stg}	-40...+175	°C

• Example of acceptable V_{GS} waveform





Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	R_{thJC}	0.42	$^{\circ}\text{C}/\text{W}$
Thermal resistance, junction – ambient. Max	R_{thJA}	40	

Electrical Characteristic (at $T_j = 25^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV_{DSS}	1200	-	-	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=100\text{uA}$
Gate threshold voltage	$\text{V}_{\text{GS(th)}}$	2.2	3	4	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=10\text{mA}$
Zero gate voltage drain current	I_{DSS}	-	1	20	μA	$\text{V}_{\text{DS}}=1200\text{V}, \text{V}_{\text{GS}}=0\text{V}$
		-	5	-		$\text{T}_C=25^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}	-		100	nA	$\text{V}_{\text{GS}}=18\text{V}, \text{V}_{\text{DS}}=0\text{V}$
Drain-source on-state resistance	$\text{R}_{\text{DS(on)}}$	-	40	52	$\text{m}\Omega$	$\text{V}_{\text{GS}}=15\text{V}, \text{I}_D=33.3\text{A}, \text{T}_J=25^{\circ}\text{C}$
		-	62	-		$\text{T}_J=175^{\circ}\text{C}$
Drain-source on-state resistance	$\text{R}_{\text{DS(on)}}$	-	32	40	$\text{m}\Omega$	$\text{V}_{\text{GS}}=18\text{V}, \text{I}_D=33.3\text{A}, \text{T}_J=25^{\circ}\text{C}$
		-	59	-		$\text{T}_J=175^{\circ}\text{C}$
Transconductance	g_{fs}	-	20	-	S	$\text{V}_{\text{DS}}=20\text{V}, \text{I}_D=33.3\text{A}$



Dynamic Characteristic

Input Capacitance	C_{iss}	-	2766	-	pF	$V_{DS} = 1000V$ $V_{GS} = 0V$ $T_J = 25^{\circ}C$ $V_{AC} = 25mV$ $f = 1MHz$
Output Capacitance	C_{oss}	-	125	-		
Reverse Transfer Capacitance	C_{rss}	-	14	-		
Gate Total Charge	Q_G	-	112	-	nC	$V_{DS} = 800V$ $V_{GS} = 0/15V$ $I_D = 33.3A$
Gate-Source charge	Q_{gs}	-	28	-		
Gate-Drain charge	Q_{gd}	-	51	-		
Turn-On Switching Energy	E_{ON}	-	701	-	μJ	$V_{DD} = 800V$ $V_{GS} = -4/+15V$ $I_D = 20A$ $R_G = 2.5\Omega$ $L = 120\mu H$
Turn-Off Switching Energy	E_{OFF}	-	79	-		
Turn-on delay time	$t_{d(on)}$	-	13.4	-		
Rise time	t_r	-	5.4	-	ns	
Turn-off delay time	$t_{d(off)}$	-	32	-		
Fall time	t_f	-	19	-		
Gate resistance	R_G	-	0.6	-	Ω	$V_{AC} = 25mV, f=1MHz$

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}		5.3		V	$V_{GS}=-4V, I_{SD}=20A, T_J=25^{\circ}C$
			4.8			$V_{GS}=-4V, I_{SD}=20A, T_J=175^{\circ}C$
Body Diode Reverse Recovery Time	t_{rr}	-	55	-	ns	$V_R = 800V$ $I_D = 33.3A$ $di/dt = 1070A/\mu S$ $T_J = 25^{\circ}C$
Body Diode Reverse Recovery Charge	Q_{rr}	-	288	-	nC	



Typical Performance Characteristics

Fig 1. Output Characteristic ($T_j = -55^\circ\text{C}$)

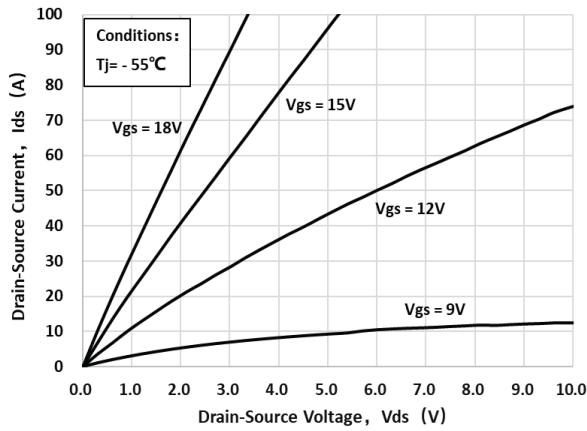


Fig 2. Output Characteristic ($T_j = 25^\circ\text{C}$)

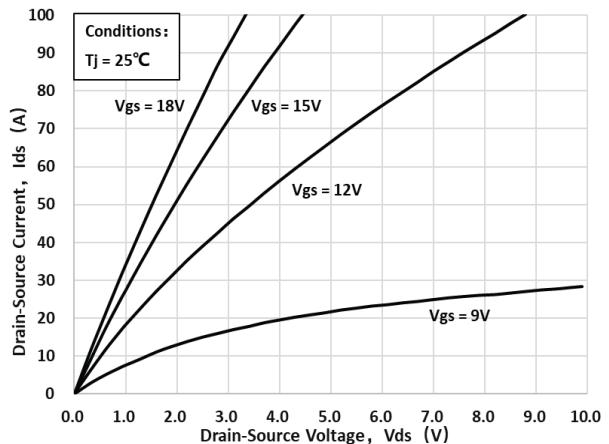


Fig 3. Output Characteristic ($T_j = 175^\circ\text{C}$)

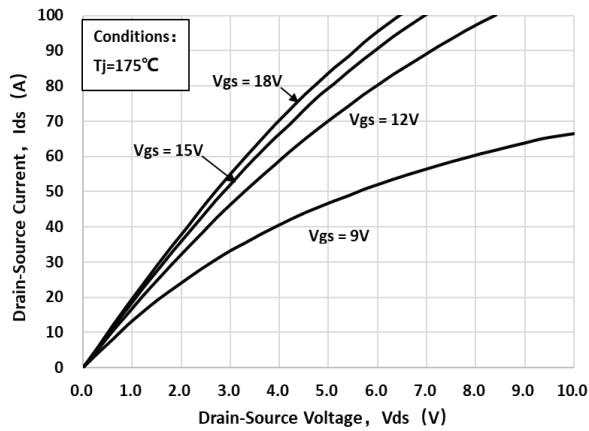


Fig 4: R_{dson} Vs Id_s Characteristic

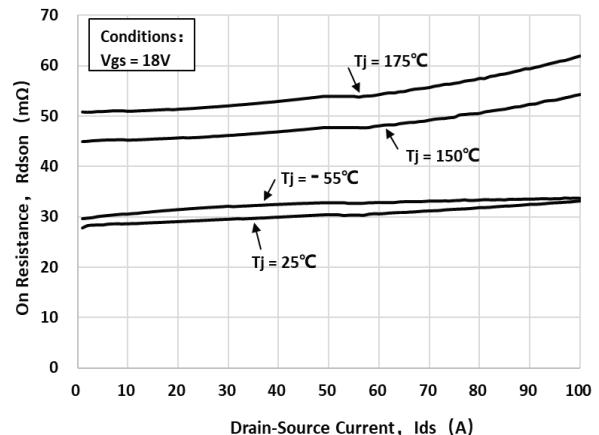


Fig 5: $R_{ds(on)}$ vs. Temperature

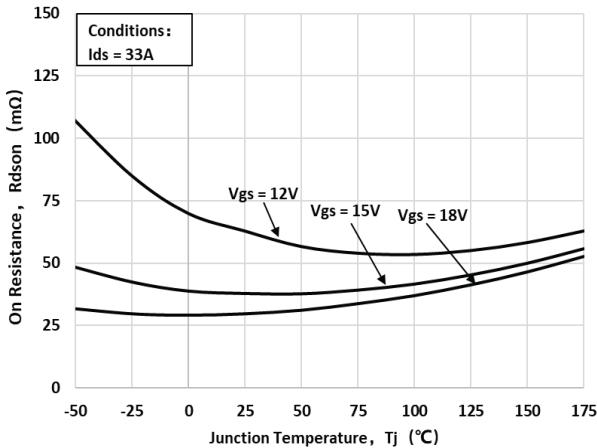


Fig 6: Transfer Characteristic

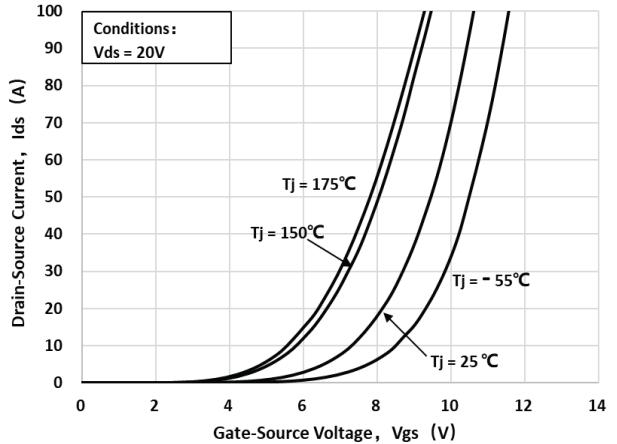




Fig 7: Body-diode Characteristic ($T_J = -55^\circ\text{C}$)

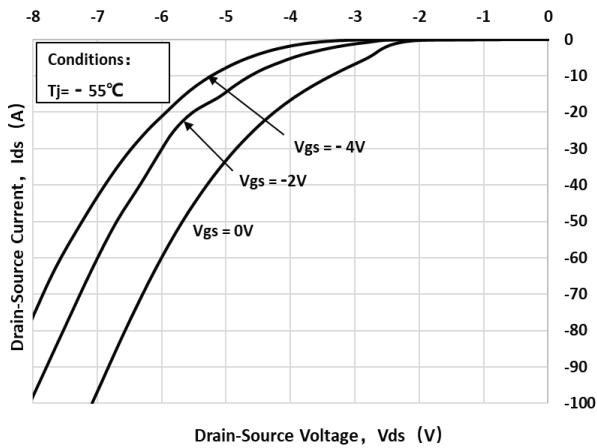


Fig 8: Body-diode Characteristic ($T_J = 25^\circ\text{C}$)

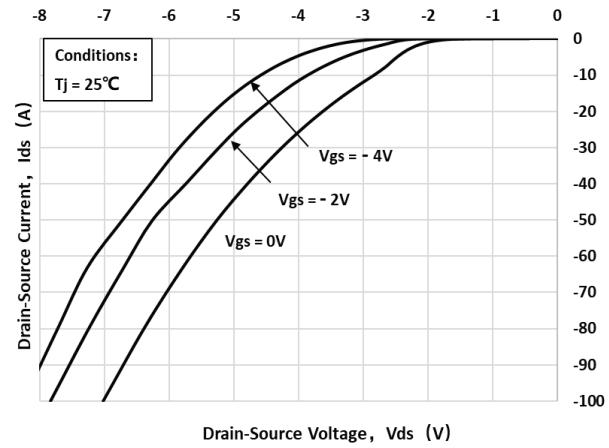


Fig 9: Body-diode Characteristic ($T_J = 175^\circ\text{C}$)

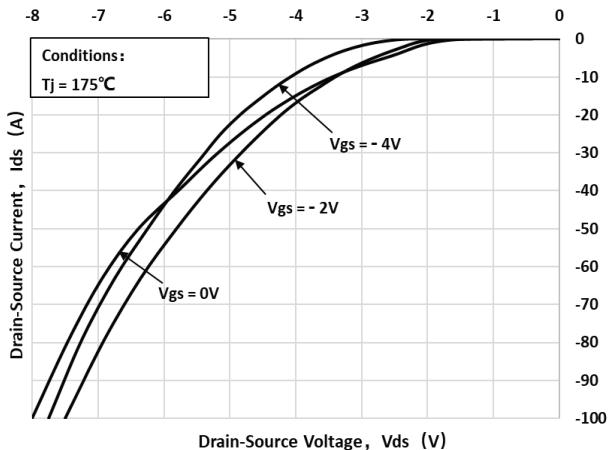


Fig 10: V_{TH} Vs T_J Temperature Characteristic

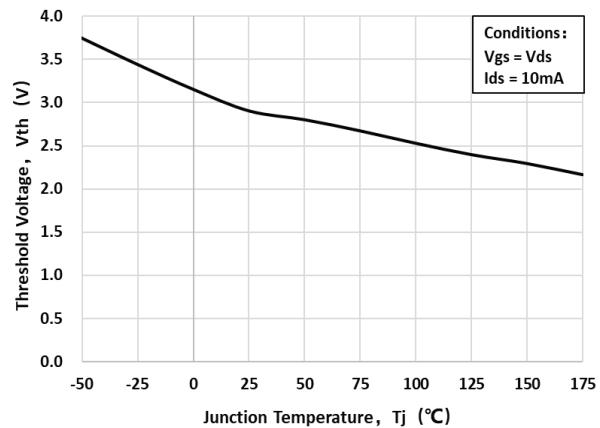


Fig 11: Gate Charge Characteristics

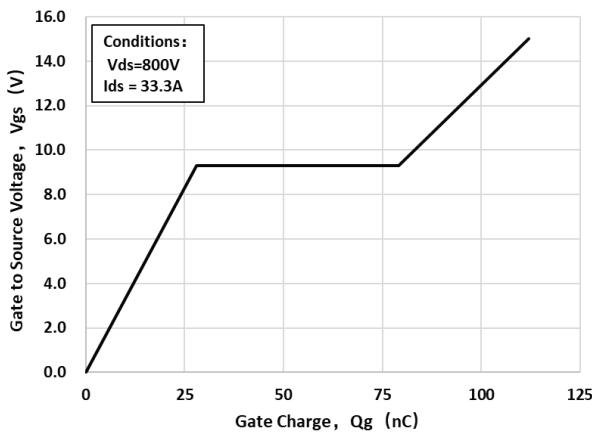


Fig 12: 3rd Quadrant Characteristic ($T_J = -55^\circ\text{C}$)

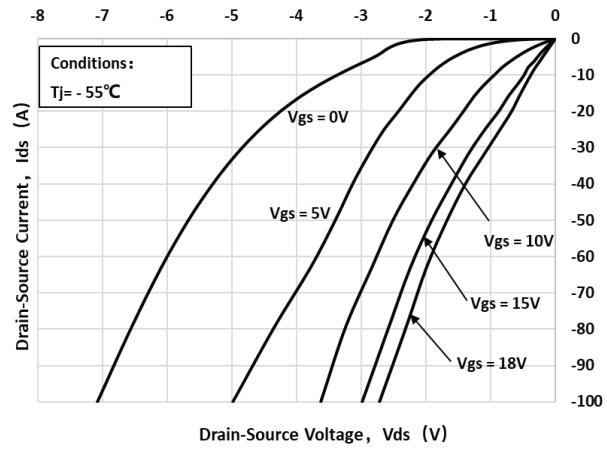




Fig 13: 3rd Quadrant Characteristic($T_j=25^\circ\text{C}$)

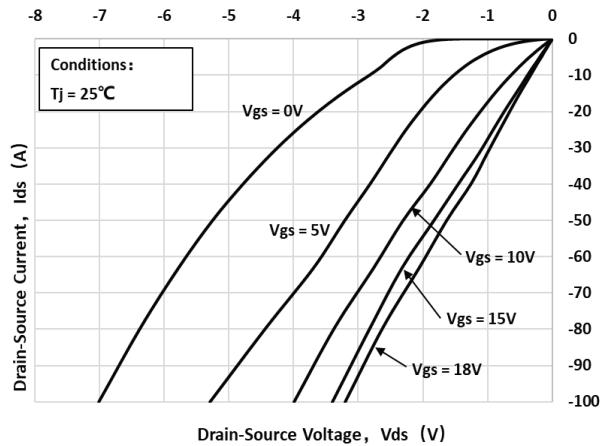


Fig 14: 3rd Quadrant Characteristic($T_j=175^\circ\text{C}$)

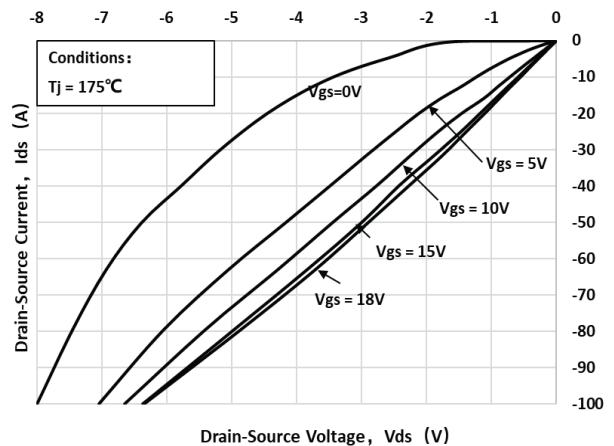


Fig 15: Capacitance Characteristic

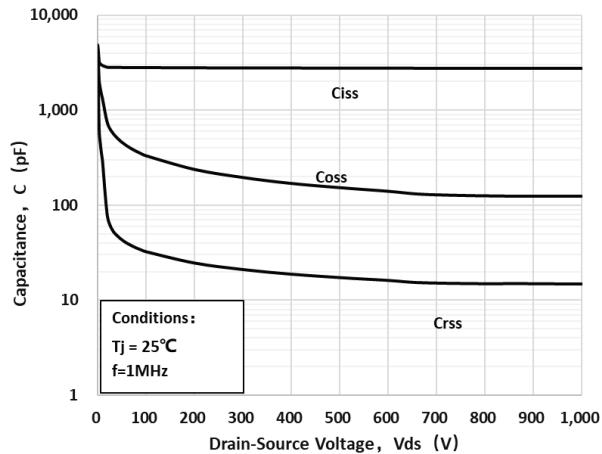
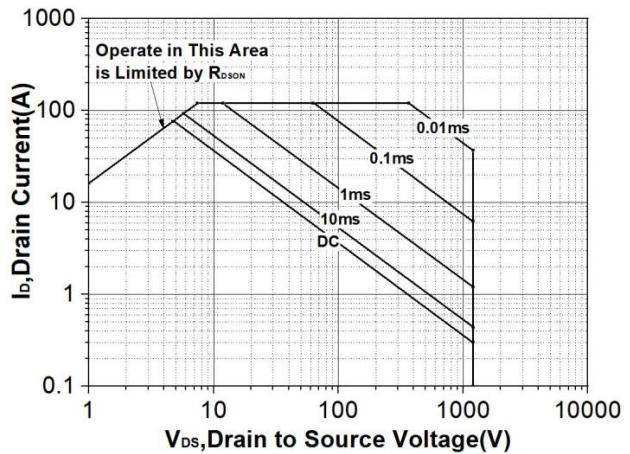


Fig 17: Transient Thermal Impedance

Fig 16: Safe Operating Area





Test Circuit & Waveform

Figure A. Definition of switching times

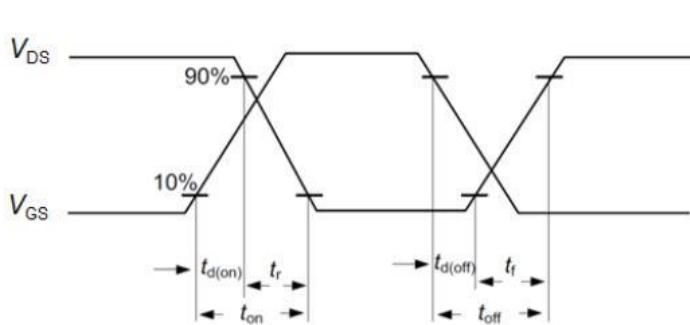


Figure B. Dynamic test circuit

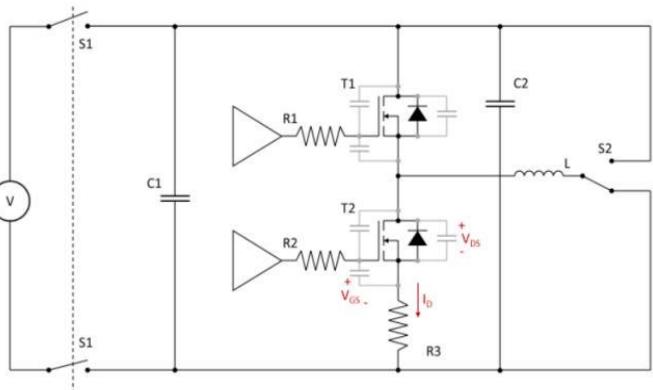


Figure C. Definition of body diode switching characteristics

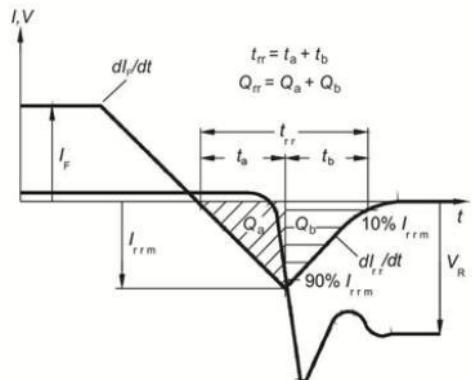
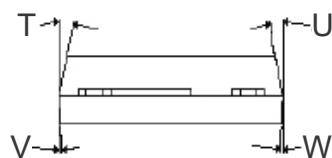
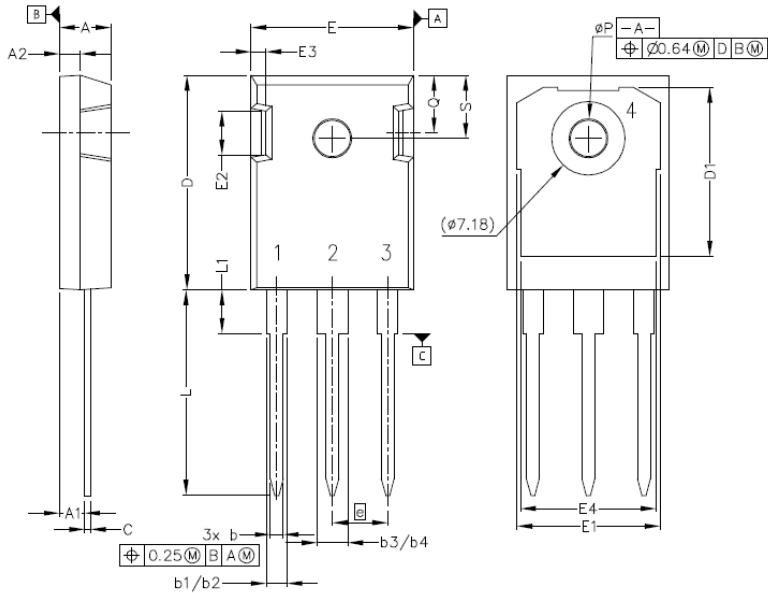


Figure C. Definition of diode switching characteristics



Package Dimensions

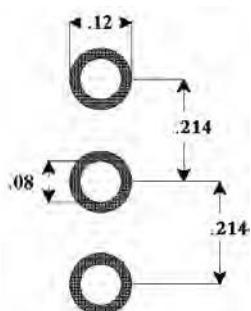
Package TO-247



Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

Recommended Solder Pad Layout



TO-247

POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.042	.052	1.07	1.33
b1	.075	.095	1.91	2.41
b2	.075	.085	1.91	2.16
b3	.113	.133	2.87	3.38
b4	.113	.123	2.87	3.13
c	.022	.027	0.55	0.68
D	.819	.831	20.80	21.10
D1	.640	.695	16.25	17.65
D2	.037	.049	0.95	1.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.10
E3	.039	.075	1.00	1.90
E4	.487	.529	12.38	13.43
e	.214 BSC		5.44 BSC	
N	3		3	
L	.780	.800	19.81	20.32
L1	.161	.173	4.10	4.40
ØP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.30
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2°	8°	2°	8°
W	2°	8°	2°	8°



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